

PATENT
450100-05490

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE 10/591204

Applicants: Sakae OKAZAKI et al.
International Application No.: PCT/JP05/01391
International Filing Date: February 1, 2005
For: AUTOFOCUS-CONTROL DEVICE AND AUTOFOCUS-
CONTROL METHOD, RECORDING MEDIUM, AND
PROGRAM

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Sir:

Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP05/01391. Also enclosed is a copy of Form PTO-1449 and the International Search Report.


REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits
are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05490	INTERNATIONAL SERIAL NO. PCT/JP05/01290 10/591204
	APPLICANT Sakae OKAZAKI et al.	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6 222 588	04/24/01	Yamazaki et al.			
	AB	6 184 932	02/06/01	Tanaka			
	AC						
	AD						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AE	7 170439	07/04/95	Japan			
	AF	7 154676	06/16/95	Japan			
	AG	5 107451	04/30/93	Japan			
	AH	6 339059	12/06/94	Japan			
	AI	2000 333072	11/30/00	Japan			
	AJ	2001 86389	03/30/01	Japan			
	AK	2001 4914	01/12/01	Japan			
	AL	2002 350716	12/04/02	Japan			
	AM	11 153748	06/08/99	Japan			
	AN	8 265619	10/11/96	Japan			
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